



# 120V N-CHANNEL ENHANCEMENT MODE MOSFET PowerDI5060-8

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> T <sub>C</sub> = +25°C
120V	$7.8$ m $\Omega$ @ V <sub>GS</sub> = 10V	90A
	$14.1 \text{m}\Omega @ V_{GS} = 4.5 \text{V}$	70A

## **Description and Applications**

This MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

PowerDI5060-8

- Switching
- DC-DC Converters

### **Features**

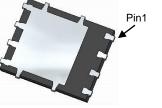
- 100% Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
- Thermally Efficient Package Cooler Running Applications
- High Conversion Efficiency
- Low R<sub>DS(ON)</sub> Minimizes On-State Losses
- <1.1mm Package Profile Ideal for Thin Applications</li>
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q101, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.
- https://www.diodes.com/quality/product-definitions/

### **Mechanical Data**

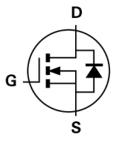
- Case: PowerDI<sup>®</sup> 5060-8
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Finish Matte Tin Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208 (§3)
- Weight: 0.097 grams (Approximate)



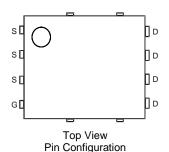
Top View



**Bottom View** 



Internal Schematic



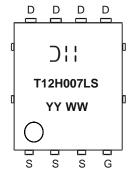
### Ordering Information (Note 4)

Part Number	Case	Packaging
DMT12H007LPS-13	PowerDI5060-8	2,500 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



☐ I Hamufacturer's Marking

T12H007LS = Product Type Marking Code

YYWW = Date Code Marking

YY = Last Two Digits of Year (ex: 19 = 2019)

WW = Week Code (01 to 53)

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# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage		$V_{DSS}$	120	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Continuous Drain Current, V <sub>GS</sub> = 10V (Note 6)	$T_C = +25$ °C $T_C = +70$ °C	I <sub>D</sub>	90 72	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)		I <sub>DM</sub>	360	А
Continuous Body Diode Forward Current (Note 6)	T <sub>C</sub> = +25°C	Is	80	А
Pulsed Body Diode Forward Current (Note 6)	$T_C = +25$ °C	I <sub>SM</sub>	360	Α
Avalanche Current, L = 3mH		I <sub>AS</sub>	15.6	А
Avalanche Energy, L = 3mH		E <sub>AS</sub>	365	mJ

# **Thermal Characteristics**

Characteristic	Symbol	Value	Unit	
Gilai acteristic	Symbol	Тур	Offic	
Total Power Dissipation (Note 5)	P <sub>D</sub>	2.9	W	
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	42	°C/W	
Total Power Dissipation (Note 6)	P <sub>D</sub>	96	W	
Thermal Resistance, Junction to Case (Note 6)	R <sub>0JC</sub>	1.3	°C/W	
Operating and Storage Temperature Range	$T_{J_1}T_{STG}$	-55 to +150	°C	

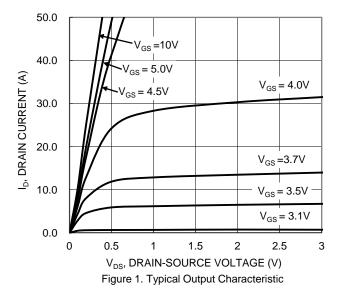
# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	120	_	_	V	$V_{GS} = 0V$ , $I_D = 10mA$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 96V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.3	_	2.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance		_	6	7.8	mΩ	$V_{GS} = 10V, I_D = 30A$	
Static Diani-Source On-Resistance	R <sub>DS(ON)</sub>	_	10	14.1	mΩ	$V_{GS} = 4.5V, I_D = 15A$	
Diode Forward Voltage	$V_{SD}$	_	0.8	1.2	V	$V_{GS} = 0V, I_{S} = 30A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		3224	_		$V_{DS} = 60V, V_{GS} = 0V,$ f = 1MHz	
Output Capacitance	Coss	_	454	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	17.8	_			
Gate Resistance	Rg	_	1.9	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	49	_			
Gate-Source Charge	$Q_{gs}$	_	11.6	_	nC	$V_{DS} = 60V, I_{D} = 25A$	
Gate-Drain Charge	$Q_{gd}$	_	11.4	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	7.9	_			
Turn-On Rise Time	t <sub>R</sub>	_	15.4	_		$V_{DD} = 60V, V_{GS} = 10V,$ $I_D = 25A, R_G = 2.7\Omega$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	30	_	ns		
Turn-Off Fall Time	t <sub>F</sub>	_	19.1	_			
Reverse Recovery Time	t <sub>RR</sub>	_	54	_	ns	1 25 A di/dt 100 A / 10	
Reverse Recovery Charge	$Q_{RR}$	_	100	_	nC	$I_F = 25A$ , di/dt = 100A/ $\mu$ s	

5. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.

- 6. Thermal resistance from junction to soldering point (on the exposed drain pad).7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.





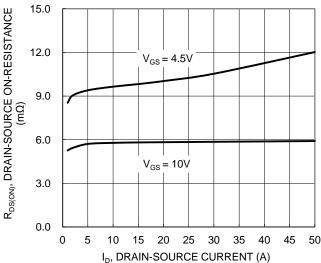


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

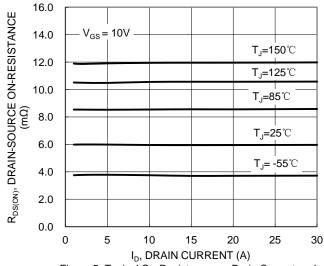


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

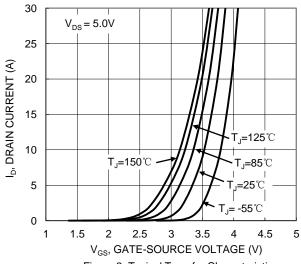


Figure 2. Typical Transfer Characteristic

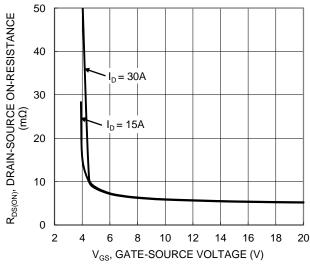


Figure 4. Typical Transfer Characteristic

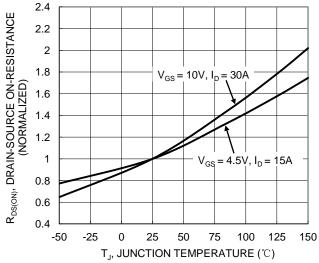


Figure 6. On-Resistance Variation with Temperature



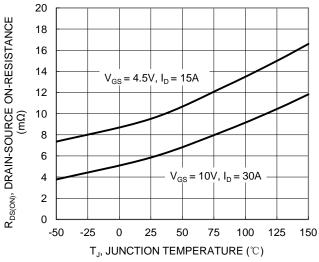


Figure 7. On-Resistance Variation with Temperature

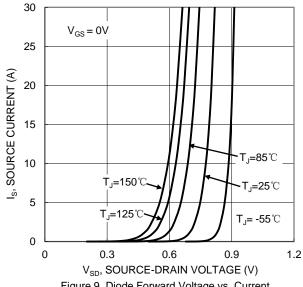


Figure 9. Diode Forward Voltage vs. Current

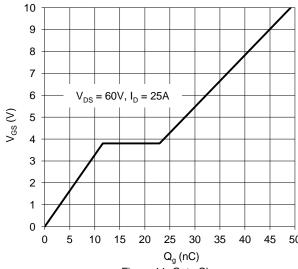


Figure 11. Gate Charge

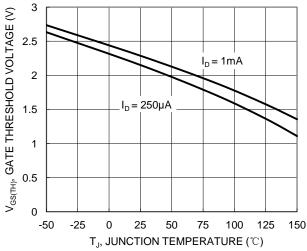
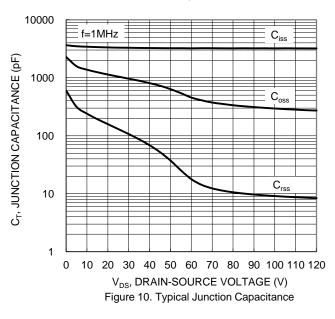


Figure 8. Gate Threshold Variation vs. Junction Temperature



1000 \_\_\_\_ 100 ID, DRAIN CURRENT (A) 10  $P_W = 100 \mu s$ T<sub>J(Max)</sub> = 150°C  $P_W = 10m$  $T_C = 25^{\circ}C$ Single Pulse 0.1 DUT on Infinite Heatsink  $V_{GS} = 10V$ 0.01 0.1 10 1000 V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



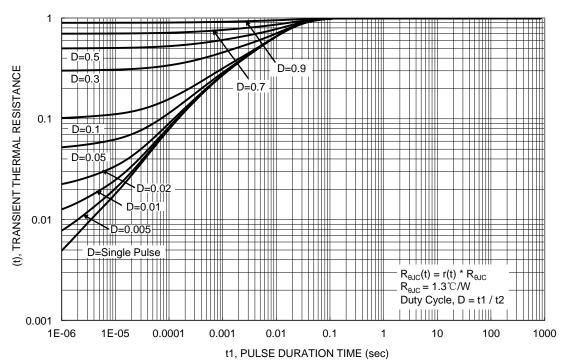


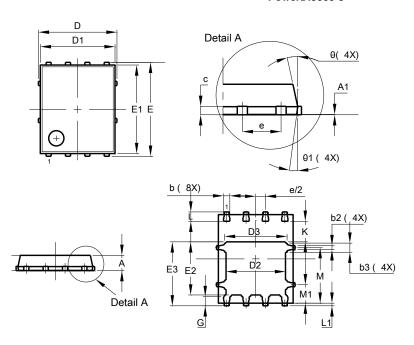
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI5060-8

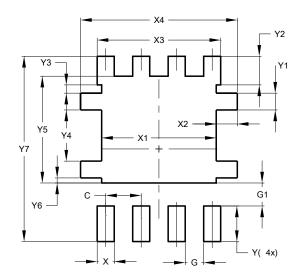


PowerDI5060-8				
Dim	Min	Max	Тур	
Α	0.90	1.10	1.00	
A1	0.00	0.05	_	
b	0.33	0.51	0.41	
b2	0.200	0.350	0.273	
b3	0.40	0.80	0.60	
С	0.230	0.330	0.277	
D		5.15 BSC	;	
D1	4.70	5.10	4.90	
D2	3.70	4.10	3.90	
D3	3.90 4.30 4.1		4.10	
Е	6.15 BSC			
E1	5.60	6.00	5.80	
E2	3.28	3.68	3.48	
E3	3.99	4.39	4.19	
е	1.27 BSC			
G	0.51	0.71	0.61	
K	0.51	-	-	
L	0.51	0.71	0.61	
L1	0.100	0.200	0.175	
М	3.235	4.035	3.635	
M1	1.00	1.40	1.21	
Θ	10°	12°	11°	
Θ1	6°	8°	7°	
All Dimensions in mm				

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI5060-8



Dimensions	Value (in mm)	
С	1.270	
G	0.660	
G1	0.820	
X	0.610	
X1	4.100	
X2	0.755	
Х3	4.420	
X4	5.610	
Y	1.270	
Y1	0.600	
Y2	1.020	
Y3	0.295	
Y4	1.825	
Y5	3.810	
Y6	0.180	
Y7	6.610	



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